

# Modeling, Synthesis, and Characterization of Thin Film Copper Oxide for Solar Cells

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## ABSTRACT

The modeling, growth, and characterization of Copper Oxide thin films for solar cell applications are reported.  $\text{Cu}_2\text{O}$  has several attractive properties which include its direct band gap ( $E_g=2.17$  eV) for use in photo-electrolysis of water and use in tandem multi-junction cells. Detailed balance calculations predict efficiencies on the order of 20% while  $\text{Cu}_2\text{O}$  cells have yet to even pass 2% efficiency. The device physics model reveals that defects, particularly at the heterojunction interface, are the main reason for lowered efficiencies. Epitaxial  $\text{Cu}_2\text{O}$  (100) thin films on MgO are fabricated using RF Oxygen plasma MBE. The films are quite smooth and showed mobilities in the range of  $10\text{--}100\text{ cm}^2/\text{V}\cdot\text{sec}$  and carrier concentrations in the range of  $10^{14}\text{--}10^{17}$ . Finally, the epitaxial growth of  $\text{Cu}_2\text{O}$  on a MgO template is demonstrated.

## INTRODUCTION

Copper Oxide ( $\text{Cu}_2\text{O}$ ) was the first semiconductor material discovered, but was soon overtaken by the fast development of silicon. Nearly 90 years after its discovery, interest in this material has renewed for use in thin film photovoltaics, as there has been much scientific progress in the development and growth of thin films. Previous work conducted on thin film photovoltaics and heterojunctions such as CIGS and CdTe has guided our investigations of  $\text{Cu}_2\text{O}$ . Copper Oxide is a non toxic semiconductor that has a direct band gap of 2.17eV, which is ideal for use in multijunction cells or for photo-electrolysis of water.[1] It also has long minority carrier diffusion length ( $\sim 10\mu\text{m}$ ) [2]. Most importantly it is composed of both earth abundant and inexpensive materials which makes the terawatt scalability of quite feasible especially if photovoltaics will play a large role in the transformation of energy from fossil fuels to solar cells.[3] Copper Oxide is intrinsically a p-type semiconductor predominately due to copper vacancies, and nearly all efforts to form homojunctions by n-doping of  $\text{Cu}_2\text{O}$  have failed. An exception is a recent report [4] in which very preliminary work was reported and no photovoltaic properties were observed. For that reason photovoltaic devices employing  $\text{Cu}_2\text{O}$  either use Schottky barriers or semiconductor heterojunctions as a mean for

charge carrier separation. For the purposes of this paper we use n-ZnO as the heterojunction partner in the devices we model and describe.

There are many reports on  $\text{Cu}_2\text{O}$  solar cells prepared by various techniques including electro-deposition, thermal oxidation of sheet metal, and sputtering deposition. [3,5,6] However, these cells have only reached energy efficiencies that are a fraction of the Shockley-Queisser theoretical value. Despite the effort of many researchers, p-n heterojunctions have yet to demonstrate good performance. Additionally the control of thin film growth and properties has not been well investigated. The lack of high quality material has resulted only in a record efficiency of 2%. [7] We investigate the growth of MBE  $\text{Cu}_2\text{O}$  in order to better understand and control material properties of our thin film, in the hopes of ultimately increasing the efficiencies of films fabricated in the future.

## MODELING

### Detailed Balance

To realize the potential of  $\text{Cu}_2\text{O}$  as both a single junction and multijunction solar cell material, it is important to explore the detailed balance thermodynamic efficiency model of single, double and triple junction solar cells. The standard AM 1.5 solar spectrum is used to determine the thermodynamic efficiency of  $\text{Cu}_2\text{O}$  at 300K under 1 sun concentration. The efficiency of a solar cell is calculated by dividing the extracted power from the cell by the integrated power of the AM 1.5 solar spectrum on the cell.

$$\eta = \frac{J(V) \cdot V}{P} \quad (1)$$

$J(V)$  is the current density generated by the cell as a function of operating voltage  $V$ . This model also makes several basic assumptions. These assumptions are that all photons greater than  $E_g$  are absorbed by the cell and create electron-hole pairs, all recombination occurs radiatively and they are non-thermal, and all absorbed photons equal the number of photons reemitted through radiative recombination plus electron-hole pairs extracted from the cell. The model also takes into account the critical

angle for emission to a medium of different refractive index. Using the geometry of a thin single-heterojunction on reflective back surface contact the efficiency is determined to be 18.74%. It is important to note that the distribution of power in the solar spectrum is broad, and it cannot be efficiently harnessed using a single band gap cell. Because the dominant sources of loss are photons with energies either greater than or less than the band gap, multijunction cells are used to more efficiently absorb the broad solar spectrum. Using  $\text{Cu}_2\text{O}$  as the top cell in both two and three junction cells, it is determined that the optimal lower cell band gap in a 2-junction cell was 1.58 eV resulting in an overall efficiency of 34.21%. In a 3-junction cell the optimal band gaps for the lower cells are determined to be 1.69 eV and 1.35 eV with an overall efficiency of 45.76%. It is important to note that all the modeled cells are current matched and running them in parallel would offer larger efficiencies.

The numbers calculated above are for ideal systems with ideal band gaps, but it is important to look at current material systems being produced to see if any of these cells will gain from being paired with  $\text{Cu}_2\text{O}$ . Using the same assumptions in the single junction model above, efficiencies of  $\text{Cu}_2\text{O}/\text{Si}$  and  $\text{Cu}_2\text{O}/\text{GaAs}$  dual junction solar cells are determined to be 27.11% and 30.08% respectively.

### Device Physics Model

The device physics model of a  $\text{Cu}_2\text{O}/\text{ZnO}$  (Fig 1) heterojunction cell will also allow one to gain a better understanding of the band structure, and to model cell performance under AM 1.5 illumination. AforS-Het (v 2.2) [8], a heterojunction device physics program developed for a-Si, is used in modeling the solar cell and calculating numerical results.

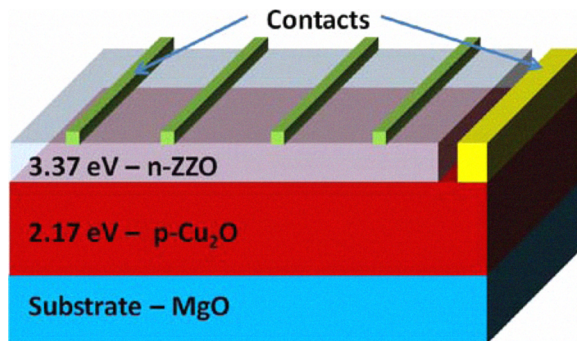
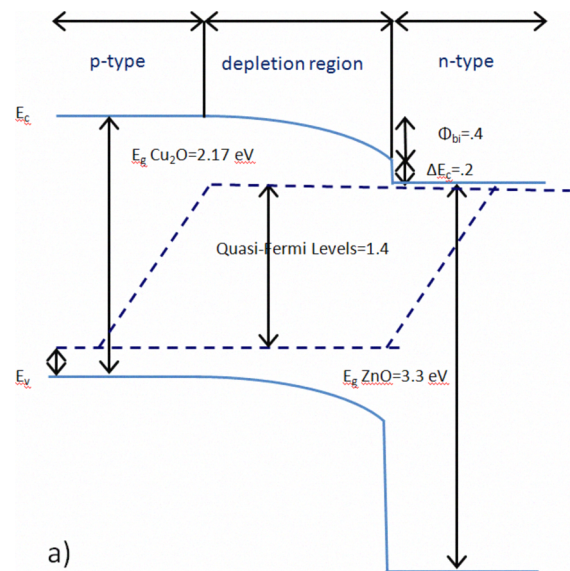


Fig. 1) Schematic of  $\text{Cu}_2\text{O}/\text{ZnO}$  solar cell.

As expected, the cell is most efficient with no traps or interface defects between the n-ZnO/p- $\text{Cu}_2\text{O}$ , and the

efficiency drops as the concentration of these defects are increased. These simulations assume Lambert-Beer's law of absorption of light and are modeled as closely as possible to materials that have currently been fabricated to date. Optical and electronic of films fabricated in lab are utilized in the simulation. The fabrication of these films will be described in the following section. Figure 2a shows the band diagram of a cell under AM 1.5 illumination. The simulated cell has a ZnO layer that is 200nm thick and a  $\text{Cu}_2\text{O}$  that is 1 $\mu\text{m}$  thick. The band offsets are determined by the electron affinity of the two heterojunction materials. The  $\text{Cu}_2\text{O}$  layer has an intrinsic carrier concentration of  $5 \times 10^{16}$  and the ZnO layer is almost degenerately doped Zn-ZnO. Figure 2 b,c shows cell performance under AM 1.5 illumination. The slightly low short circuit currents can be attributed to defect and interface recombination. The high Voc's are encouraging as many heterojunctions fabricated previously have Voc's a fraction (20%) of these values. The fill factors are strongly dependent on the series resistance of the cells and can greatly vary depending on the doping and mobility of thin film layers as well as contact resistance which is not taken into account in these simulations. The external quantum efficiency calculated for the carrier concentration of  $5 \times 10^{16}$  is as expected. The higher values both in Voc and QE can be attributed to modeling a higher quality interface that is possible to be fabricated using MBE.



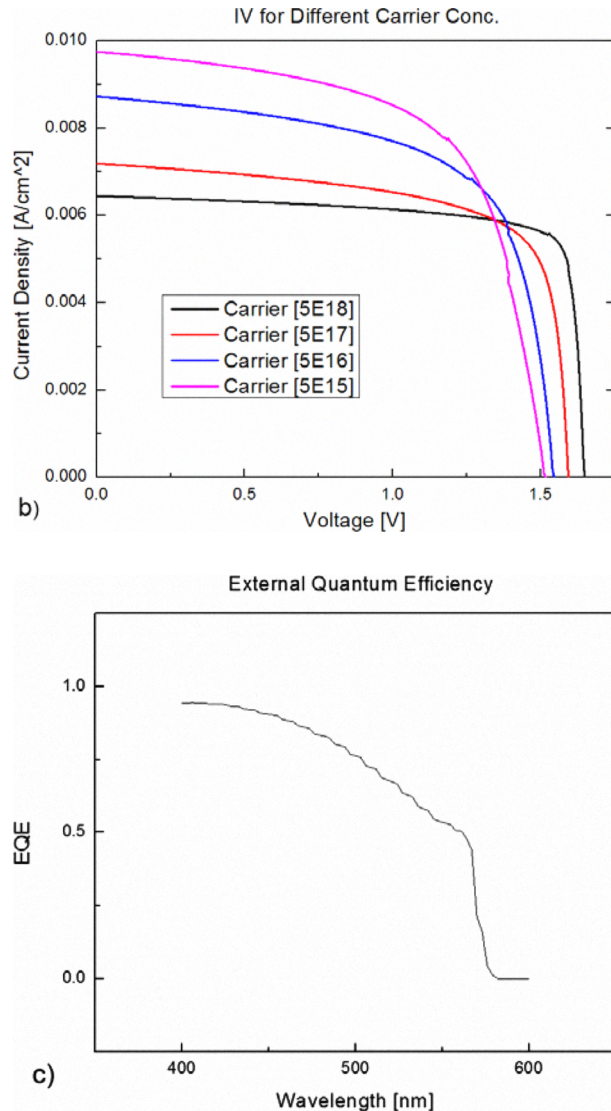


Fig. 2.a) Band diagram of ZnO/Cu<sub>2</sub>O heterojunction under AM1.5 illumination. b) IV Curves of cells with different carrier concentration for Cu<sub>2</sub>O layer under AM 1.5 illumination. c) EQE of cell with carrier concentration of  $5 \times 10^{16}$  under AM 1.5 illumination.

## EXPERIMENT

From the insight that was gained from modeling, Molecular Beam Epitaxy (MBE) seemed to be the best method to fabricate the solar cells, as it provides the greatest control over critical growth conditions such as temperature, flux, base pressure, and interface sharpness. We used cubic Magnesium Oxide (MgO (100),  $a=4.22\text{\AA}$ ) as our substrate with a low lattice mismatch of 1.1% between Cu<sub>2</sub>O ( $a=4.27\text{\AA}$ ) and the substrate. We used a copper effusion cell operating through a temperature range  $T=1050^{\circ}\text{C}$ -  $T=1080^{\circ}\text{C}$  and oxygen partial pressure  $10^{-4}$  -  $10^{-6}$ . By varying the oxygen partial pressure and copper effusion rate, we were able to change properties of the film including doping. The optimal conditions were determined to be  $T=1060^{\circ}\text{C}$  for the Knudsen Copper effusion cell, with a substrate temperature of  $T=650^{\circ}\text{C}$ . The thin films were grown in the presence of a RF oxygen plasma ( $P=300\text{W}$ ) at  $10^{-6}$  torr. Several different post deposition annealing steps were explored to create the highest quality film. In-situ characterization of our film was done with Reflective High Energy Electron Diffraction (RHEED). Further analysis was done via x-ray diffraction and EDS to confirm the material grown and crystallinity, as well as Hall measurements to obtain the electrical properties of our film.

## RESULTS

Cu<sub>2</sub>O is one of two Cu/O stoichiometries. Because of this it was very important to control the growth of the film; especially the flux of Cu and O. An active Oxygen plasma allowed the film to grow at a much lower pressure by making the more reactive atomic oxygen available instead of molecular oxygen. As mentioned previously, MgO was used as the growth substrate. Both the substrate and Cu<sub>2</sub>O have a cubic crystal structure and closely matched lattice parameters. We observed that cube on cube epitaxial Cu<sub>2</sub>O was grown on the MgO substrate. In-situ RHEED was used to confirm the epitaxial growth, which can be seen in Figure 3. RHEED

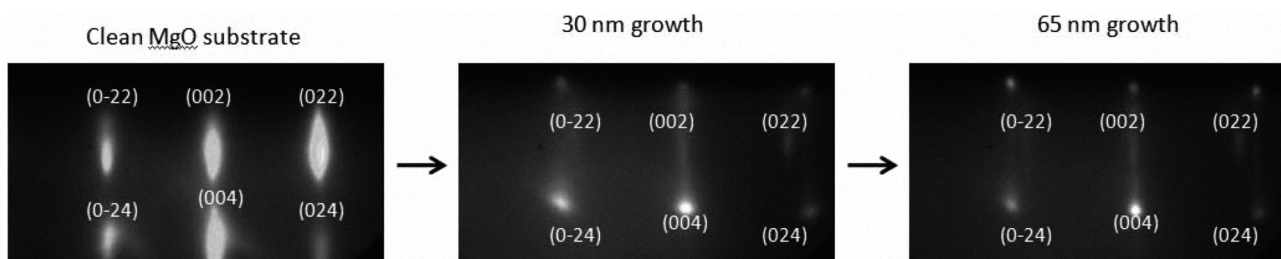


Fig. 3) In-situ RHEED images of epitaxial Cu<sub>2</sub>O on MgO bulk substrate with diffraction spots indexed.



oscillations were observed, indicating that the thin film was growing in a layer-by-layer growth regime, typically seen if growth of the film can be well controlled and grown slowly (approximately .2 Å/sec). In addition, the streaky nature of the RHEED image indicated that the film is very smooth. X-ray diffraction was conducted on the thin film samples post growth to confirm epitaxy as well as X-ray diffraction of Cu<sub>2</sub>O on MgO to determine the stoichiometry of the film.

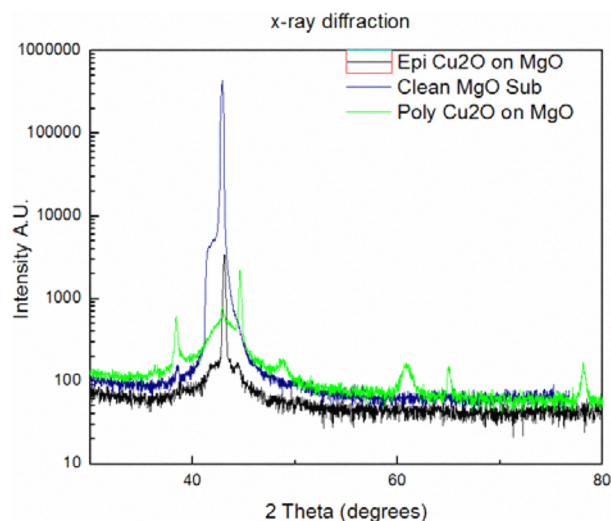


Fig. 4) x-ray diffraction of Cu<sub>2</sub>O on MgO Sub.

Energy Dispersive X-ray Spectroscopy further confirmed the composition of the film and did not indicate impurities in the film. Hall mobility measurements showed mobilities in the range of 10-100 cm<sup>2</sup>/V\*sec and carrier concentrations in the range of 10<sup>14</sup>-10<sup>17</sup>, which is dependent on substrate temperature and oxygen plasma partial pressure. A very smooth film and the ability of in-situ passivation of our interface will hopefully provide the quality interface needed to achieve much higher cell efficiencies. Optical ellipsometry was conducted on the films to determine index of refraction and absorption (see Fig 5). The data measured was subsequently used on other samples to verify film thicknesses and quality post growth.

Very thin template layers on the order of 15 -30 nm of MgO (100) were also grown using Ion Beam Assisted Deposition (IBAD) on cheap and amorphous substrates. IBAD e-beam MgO was deposited on top of Silicon Nitride and other cheap substrates, thus eliminating the need of using costly MgO substrates. In addition, because the template is thin, the resulting film that is grown on top will be less strained and consequently

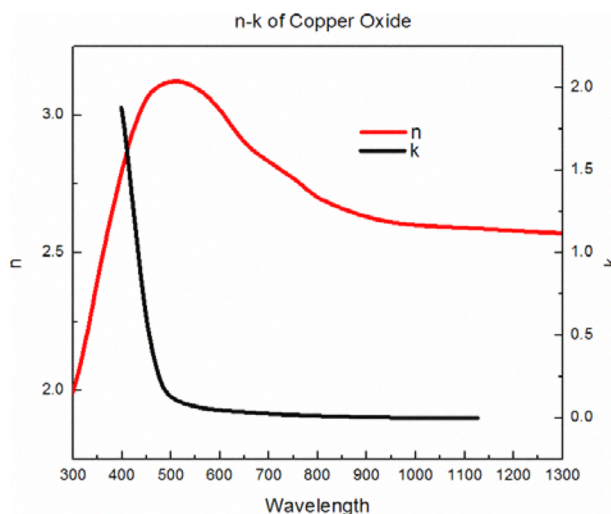


Fig. 5) Measured n-k optical data for Cu<sub>2</sub>O using spectroscopic ellipsometry.

will be of higher quality. As discussed earlier in the modeling section of this paper, the advantage of Cu<sub>2</sub>O solar cells may be used in multijunction tandem cells. IBAD MgO can significantly lower the cost of the overall cell, and makes it convenient to integrate with existing cells as several commercial cells on the market today use Si<sub>3</sub>N emitter layers thus making growth of our Cu<sub>2</sub>O cell on top of existing cells fairly easy. Figure 6 shows RHEED images of IBAD MgO grown on an amorphous SiO<sub>2</sub> layer. Subsequent epitaxial deposition of Cu<sub>2</sub>O was observed.

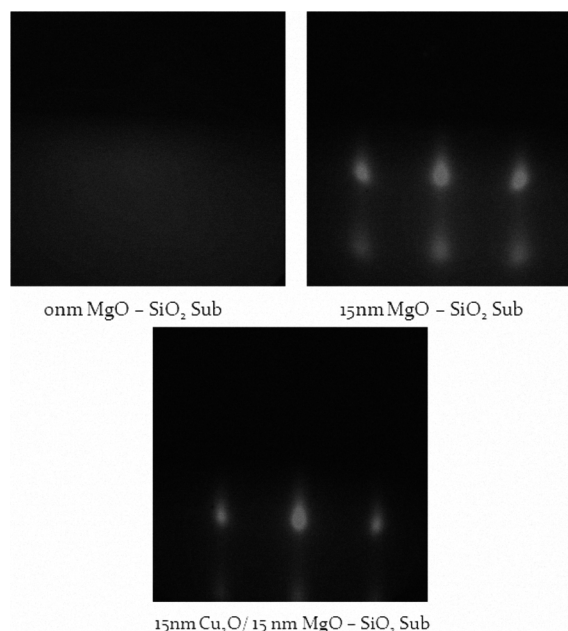


Fig. 6) Cu<sub>2</sub>O/IBAD MgO grown on SiO<sub>2</sub>.

## CONCLUSION

A thermodynamic detailed balance model was used to obtain ultimate efficiencies of both single and multijunction solar cells made with a  $\text{Cu}_2\text{O}/\text{ZnO}$  heterojunction. The most efficient band gaps were also determined for multijunction cells under AM 1.5 illumination. The device physics model of the  $\text{Cu}_2\text{O}$  cell explored the effects of material quality, surface, and interface quality as well as identifying the target electrical properties the films should have. Current solar cell technologies on the market were also considered for use in  $\text{Cu}_2\text{O}$  multijunction tandem cells. These tandem cell combination detailed balance thermodynamic efficiencies were also calculated. MBE growth of epitaxial  $\text{Cu}_2\text{O}$  was demonstrated on (100)  $\text{MgO}$ . Structural and electrical qualities of the film were characterized using RHEED, x-ray diffraction, EDS, and Hall mobility measurements. Further characterization of material quality via PL lifetime and TEM are underway and will be reported in the future in order to help characterize quality of our material and junctions.

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